

Search Notes**Application/Control No.**

09/664,855

Examiner

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Applicant(s)/Patent under Reexamination

ENOKI ET AL.

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
455	574	2/12/2003	HN
	572		
	127.5		
	343.1		
	435.1		
	343.2		
	343.5		
Updated	search	9/22/2005	HN
Updated	search	9/21/2006	HN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East; Text search (USPAT, US- PGPUB, JPO, EPO, DERWENT). See search history printout.	9/22/2005	HN
East; Text search (USPAT, US- PGPUB, JPO, EPO, DERWENT). See search history printout.	9/21/2006	HN